

TEST REPORT

- **APPLICANT** : ShenZhen Gospell Smarthome Electronic Co., Ltd.
- PRODUCT NAME : HD WiFi Camera
- MODEL NAME : T5886HAA, T5886F
- BRAND NAME : N/A
- STANDARD(S) : 47 CFR Part 15 Subpart B
- **TEST DATE** : 2017-10-31 to 2017-11-17
- **ISSUE DATE** : 2017-11-24

Tested by:

Wu Zhorgven

Wu Zhongwen (Test Engineer)

Approved by:

Andy Yeh(Technical Director)

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DIRECTORY

1. Technical Information	3
1.1. Applicant and Manufacturer Information	3
1.2. Equipment Under Test (EUT) Description	3
2. Test Results	••• 4
2.1. Applied Reference Documents	4
2.2. EUT Setup and Operating Conditions	5
3. 47 CFR Part 15B Requirements	6
3.1. Conducted Emission	6
3.2. Radiated Disturbance	· 10
Annex A Photographs of Test Setup	· 15
Annex B Test Uncertainty	· 17
Annex C Testing Laboratory Information	· 18

Change History				
Issue	Date	Reason for change		
1.0	2017-11-24	First edition		





Note: Provide by applicant.

1.1. Applicant and Manufacturer Information

Applicant:	ShenZhen Gospell Smarthome Electronic Co., Ltd.					
Applicant Address:	5Floor/Block 2, Vision (SZ) Park, Hi-Tech Industrial Park,					
	Shenzhen, China					
Manufacturer:	ShenZhen Gospell Smarthome Electronic Co., Ltd.					
Manufacturer Address:	East of01st-04stFloor,Block A,No.1 Industrial park,					
	Fenghuanggang, South of No.1 Baotian Road, Xixiang street,					
	Bao'an District, Shenzhen City, Guangdong Province					
	518126,P.R.China					

1.2. Equipment Under Test (EUT) Description

EUT Type:	HD WiFi Camera		
Serial No:	(N/A, marked #1 by test site)		
Hardware Version:	T5886HAA_M03		
Software Version:	E_900.T5886HAA.010.	323	
Tx Frequency:	802.11b/g/n: 2412 MHz ~ 2462 MHz		
Rx Frequency:	802.11b/g/n: 2412 MHz ~ 2462 MHz		
Ancillary	AC Adapter		
Equipment:	Brand Name:	KUANTEN	
	Model No.:	KT05W050100USU	
	Serial No.: (N/A, marked #1 by test site)		
	Rated Input:	~ 100-240V, 50/60Hz, 0.2A	
	Rated Output:	==5V,1A	

Note:

- 1. There are two models of samples (T5886HAA and T5886F), they differ in Model No.
- 2. For a more detailed description, please refer to specification or user's manual supplied by the applicant and/or manufacturer.





2.1. Applied Reference Documents

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

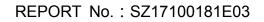
No.	Identity	Document Title
1	47 CFR Part 15	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Test Date	Test Engineer	Result
1	15.107	Conducted Emission	2017.11.15	Wu Zhongwen	PASS
2	15.109	Radiated Emission	2017.11.16	Wu Zhongwen	PASS

NOTE: The tests were performed according to the method of measurements prescribed in ANSI C63.4-2014.







2.2. EUT Setup and Operating Conditions

Frequency range was investigated: Conducted emission test: from 150 KHz to 30 MHz; Radiated emission test: from 30 MHz to 6000 MHz.

Test Item	Test Item				
Radiated Emission					
Mode 1		EUT + Adapter			
Conducted Emission					
Mode 1	:	EUT + Adapter			

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15 - 35
Relative Humidity (%):	30 - 60
Atmospheric Pressure (kPa):	86 - 106





3. 47 CFR Part 15B Requirements

3.1. Conducted Emission

3.1.1. Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the ACpower line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in thefollowing table, as measured using a 50μ H/50 Ω line impedance stabilization network (LISN).

Frequency range	Conducted Limit (dBµV)			
(MHz)	Quasi-peak	Average		
0.15 - 0.50	66 to 56	56 to 46		
0.50 - 5	56	46		
5 - 30	60	50		

NOTE:

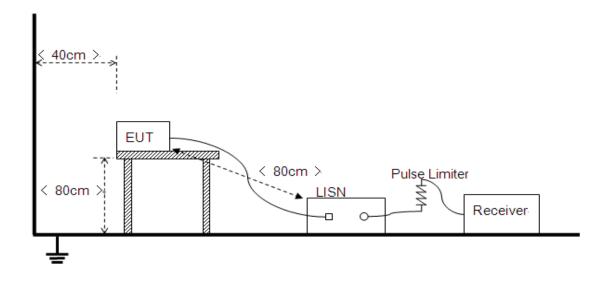
a) The limit subjects to the Class B digital device.

b) The lower limit shall apply at the band edges.

c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50MHz.

3.1.2. Test Setup

Please refer to Annex A for the photographs of the Test Configuration.





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The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides $50\Omega/50\mu$ H of coupling impedance for the measuring instrument. A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

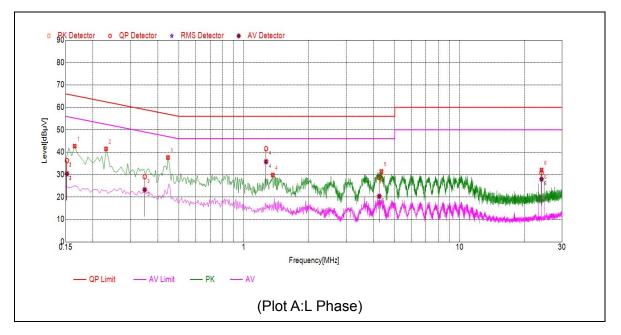
The power strip or extension cord has been investigated to make sure that the LISN integrity in maintained with respect to the impedance characteristics as prescribed in ANSI C63.4-2014 at Clause 4.3.

3.1.3. Test Result

The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors.Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.





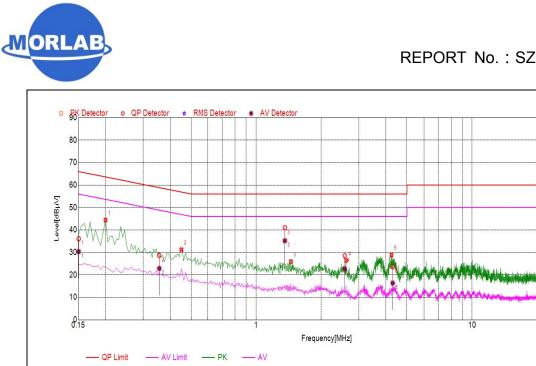


A. Test Plot and Suspicious Points:

NO.	Fre.	Emission L	evel (dBµV)	Limit (dBµV)		Power-line	Verdict
NO.	(MHz)	Quai-peak	Average	Quai-peak	Average	Power-line	verdict
1	0.152	36.23	30.36	65.89	55.89		PASS
2	0.1512	36.20	30.41	65.93	55.93		PASS
3	0.3476	29.04	23.26	59.02	49.02	Line	PASS
4	1.271	41.56	35.78	56.00	46.00	Line	PASS
5	4.2454	28.74	20.34	56.00	46.00		PASS
6	24.000	30.80	27.98	60.00	50.00		PASS



30



(Plot B: N Phase)

NO.	Fre.	Emission L	evel (dBµV)	Limit (dBµV)		Power-line	Verdict
NO.	(MHz)	Quai-peak	Average	Quai-peak	Average	Power-line	verdict
1	0.1506	36.11	30.34	65.97	55.97		PASS
2	0.3558	28.67	22.86	58.83	48.83		PASS
3	1.3592	41.01	35.20	56.00	46.00	Noutral	PASS
4	2.5716	28.49	22.74	56.00	46.00	Neutral	PASS
5	4.295	23.70	16.35	56.00	46.00		PASS
6	24.001	29.67	27.99	60.00	50.00		PASS



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3.2. Radiated Disturbance

3.2.1. Requirement

According to FCC section 15.109 (a), the field strength of radiated emissions from unintentionalradiators at a distance of 3 meters shall not exceed the following values:

Frequency	Field Strength Limitation at 3m Measurement Dist				
range (MHz)	(µV/m)	(dBµV/m)			
30.0 - 88.0	100	20log 100			
88.0 - 216.0	150	20log 150			
216.0 - 960.0	200	20log 200			
Above 960.0	500	20log 500			

As shown in FCCsection 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.

Note:

- 1) The tighter limit shall apply at the boundary between two frequency range.
- 2) Limitation expressed in dB μ V/m is calculated by 20log Emission Level(μ V/m).

3.2.2. Frequency range of measurement

According to 15.33(b)(1), the frequency range of radiated measurement for the EUT is listed in the following table:

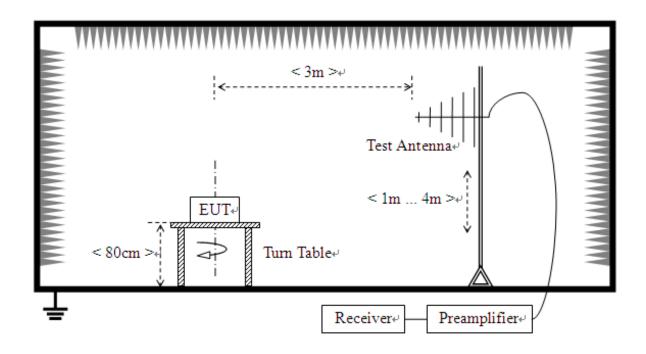
Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measure- ment range (MHz)
Below 1.705 1.705–108 108–500 500–1000 Above 1000	30. 1000. 2000. 5000. 5th harmonic of the highest frequency or 40 GHz, whichever is lower.



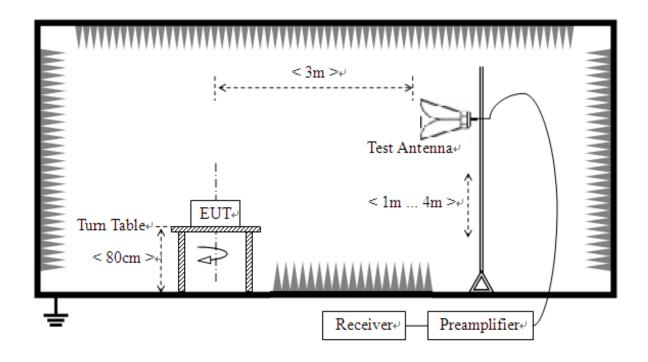


3.2.3. Test Setup

1) For radiated emissions from 30MHz to1GHz



2) For radiated emissions above 1GHz





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The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on avariable-height antenna master tower.

For the test Antenna:

In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

3.2.4. Test Result

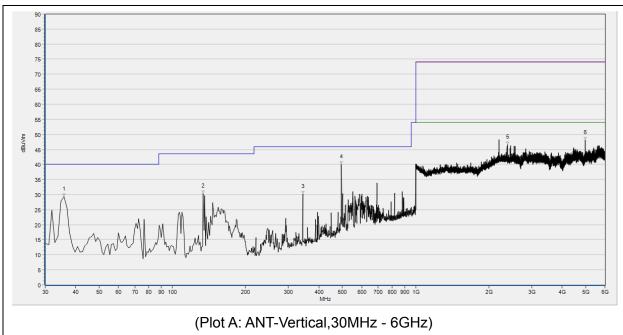
The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of emissions (6GHz-12.5GHz) which are attenuated more than 20 dB below the permissible value need not be reported.

Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.



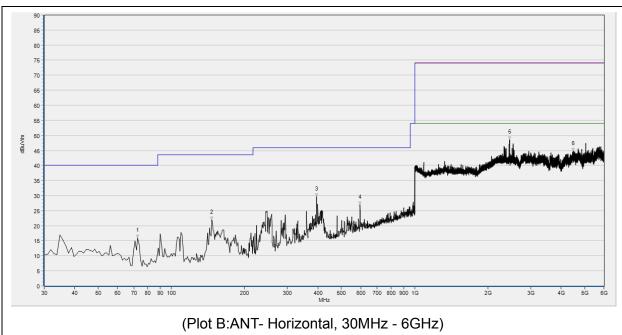




No.	Fre.	Pk	QP	AV	Limit-PK	Limit-QP	Limit-AV	ANT	Verdict
NO.	MHz	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	ANT	verdict
1	35.820	N.A.	29.37	N.A.	N.A.	40.00	N.A.	V	PASS
2	133.790	N.A.	30.26	N.A.	N.A.	43.50	N.A.	V	PASS
3	343.310	N.A.	30.16	N.A.	N.A.	46.00	N.A.	V	PASS
4	494.630	N.A.	40.12	N.A.	N.A.	46.00	N.A.	V	PASS
5	2382.933	46.59	N.A.	39.25	74.00	N.A.	54.00	V	PASS
6	4971.840	48.10	N.A.	41.51	74.00	N.A.	54.00	V	PASS







Na	Fre.	Pk	QP	AV	Limit-PK	Limit-QP	Limit-AV		Vardiat
No.	MHz	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	ANT	Verdict
1	72.680	N.A.	15.88	N.A.	N.A.	40.00	N.A.	н	PASS
2	146.400	N.A.	22.04	N.A.	N.A.	43.50	N.A.	н	PASS
3	395.690	N.A.	29.61	N.A.	N.A.	46.00	N.A.	Н	PASS
4	596.480	N.A.	27.01	N.A.	N.A.	46.00	N.A.	Н	PASS
5	2457.600	48.67	N.A.	41.54	74.00	N.A.	54.00	Н	PASS
6	4482.920	44.76	N.A.	37.21	74.00	N.A.	54.00	Н	PASS





Annex A Photographs of Test Setup

1. Mains Terminal Disturbance Voltage Measurement



2. Conducted emission main's port side





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3. Radiated Field Strength Measurement(30MHz-1GHz)

4. Radiated Field Strength Measurement(above 1GHz)





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Annex B Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission Measurement

Measuring Uncertainty for	9kHz-150kHz	±4.1 dB
a Level of Confidence of	150kHz-30MHz	±3.7dB
95%(U=2Uc(y))		

Uncertainty of Radiated Emission Measurement

Measuring Uncertainty for	30MHz-200MHz	±5.06dB
a Level of Confidence of	200MHz-1000MHz	±5.24dB
95%(U=2Uc(y))	1GHz-6GHz	±5.18dB
	6GHz-18GHz	±5.48dB



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Annex C Testing Laboratory Information

1. Identification of the Responsible Testing Laboratory

Company Name:	Shenzhen Morlab Communications Technology Co., Ltd.				
Department:	Morlab Laboratory				
Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang Road, Block 67, BaoAn District, ShenZhen, GuangDong Province, P. R. China				
Responsible Test Lab Manager:	Mr. Su Feng				
Telephone:	+86 755 36698555				
Facsimile:	+86 755 36698525				

2. Identification of the Responsible Testing Location

Name:	Shenzhen Morlab Communications Technology Co., Ltd.
	Morlab Laboratory
	FL.3, Building A, FeiYang Science Park, No.8 LongChang
Address:	Road, Block 67, BaoAn District, ShenZhen, GuangDong
	Province, P. R. China

3. Accreditation Certificate

Accredited Testing	The FCC designation number is CN1192.
Laboratory:	(Shenzhen Morlab Communications Technology Co., Ltd.)

4. Test Software Utilized

Model	Version Number	Producer
MORLAB EMCR V1.2	Version 1.0	MORLAB
TS+ -[JS32-CE]	Version2.5.0.0	Tonscend





5. Test Equipments Utilized

Description	Manufacturer	Model	Serial No.	Cal. Date	Due. Date
MXE EMI Receiver	Agilent	N9038A	MY54130016	2017.05.17	2018.05.16
Receiver	KEYSIGHT	N9038A	MY56400093	2017.07.13	2018.07.12
LISN	Schwarzbeck	NSLK 8127	812744	2017.05.17	2018.05.16
Pulse Limiter (20dB)	VTSD	9561D	9537	2017.05.17	2018.05.16
Test Antenna - Bi-Log	Schwarzbeck	VULB 9163	VULB9163-274	2016.12.09	2017.12.08
Test Antenna - Horn	Schwarzbeck	BBHA 9120D	1774	2017.09.13	2018.09.12
Semi-Anechoic Chamber	Changning	9m*6m*6m	N/A	2017.01.11	2018.01.10

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